plus sign (+) inside this box ™ U.S. Patent and Trademark Office; U.S. DEPARTMENT OF COMMERCE Under the Paperwork Reduction Act of 1995, no persons are required to respond to a collection of information unless it contains a valid OMB control number **Application Number** MAR 2 6 2004 10/076,121 Substitute for form 1449A/PTO Filing Date 2/12/02 INFORMATION DISCLOSURE First Named Inventor Steven Teig CORARSTATEMENT BY APPLICANT Group Art Unit Do, Thuan (use as many sheets as necessary) **Examiner Name** 2825 of Sheet 13 SPLX.P0081 Attorney Docket Number **U.S. PATENT DOCUMENTS** U.S. Patent Document Date of Cite Pages, Columns, Lines, Examiner Name of Patentee or Applicant Kind Code **Publication** Number Where Relevant Passages or Initials No. of Cited Document (if known) MM-DD-YYYY Relevant Figures Appear 2002/0100 てり 1. **A1** 07-25-2002 Xing et al. 009 2002/0104 2. **A1** 08-01-2002 Xing et al. 061 2002/0107 3. **A1** 08-08-2002 Xing et al. 711 2002/0182 4. **A1** 12-05-2002 Igarashi et al. 844 2003/0005 5. A1 01-02-2003 Igarashi et al. 399 2003/0188 6. A1 10-02-2003 Xing 281 7. 4,615,011 09-30-1986 Linsker 8. 4,782,193 11-01-1988 Linsker 9. 5,633,479 05-27-1997 Hirano 10. 5,634,093 05-27-1997 Ashida et al. 11. 5,635,736 06-03-1997 Funaki et al. 12. 6,128,767 10-03-2000 Chapman 6,219,823 13. **B1** 04-17-2001 Hama et al. 14. 6,226,560 **B1** 05-01-2001 Hama et al. 15. 6,262,487 **B1** 07-17-2001 Igarashi et al. 16. 6,295,634 **B1** 09-25-2001 Matsumoto 17. 6,436,804 B₂ 08-20-2002 loarashi et al.

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Application Number 10/076,121 Substitute for form 1449A/PTO TA MARINE 2/12/02 **Filing Date** INFORMATION DISCLOSURE First Named Inventor Steven Teig STATEMENT BY APPLICANT Group Art Unit Do, Thuan (use as many sheets as necessary) 2825 **Examiner Name** Sheet of SPLX.P0081 6 13 Attorney Docket Number **FOREIGN PATENT DOCUMENTS** translation of the application. with English translation JP 104 04-000677 01-06-1992 TDFujiwara et al. of Abstract; with Japanese Patent Office's English translation of Abstract; 105 JP 05-102305 04-23-1993 Sato T N and with English translation of the application. with Japanese Patent Office's English translation of Abstract; $G \cap \mathcal{F}$ JP 05-243379 106. 09-21-1993 Kubota and with English translation of the application. with Japanese Patent Office's English 10 translation of Abstract; 107. JP 07-86407 03-31-1995 Miura and with English translation of the application. with Japanese Patent Office's English TD translation of Abstract; 108. JP 09-162279 06-20-1997 Yoshida and with English translation of the application.

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Based on PTO/SB/08 a & b (05-03) Approved for use through 05/31/2003. OMB 0851-0031 U.S. Patent and Trademark Office; U.S. DEPARTMENT OF COMMERCE sign (+) inside this box Under the Paperwork Reduction Act of 1995, no persons are required to respond to a collection of information unless it contains a valid OMB control number **Application Number** Substitute for form 1449A/PTO 10/076,121 2/12/02 Filing Date INFORMATION DISCLOSURE First Named Inventor Steven Teig STATEMENT BY APPLICANT **Group Art Unit** Do, Thuan (use as many sheets as necessary) 2825 **Examiner Name** Sheet 9 13 SPLX.P0081 Attorney Docket Number NON PATENT LITERATURE DOCUMENTS Andou, H. et al., Automatic Routing Algorithm for VLSI, 22nd Design Automation Conference, 1985, pp. 139 Bagga, J. et al., Internal, External, and Mixed Visibility Edges of Polygons. TD Berger, B. et al., Nearly Optimal Algorithms and Bounds for Multilayer Channel Routing, Journal of the TD Association for Computing Machinery, pp. 500-542, March 1995. Brady, L. et al., Channel Routing on a 60° Grid, extended abstract, pp.926-931. 141 TD Carothers, K., A Method of Measuring Nets Routability for MCM's General Area Routing Problems, $\mathcal{T}\mathcal{O}$ 1999, pp. 186-192. Chen, D-S. et al., A Wire-Length Minimization Algorithm for Single-Layer Layouts 143 てり Chen et al., Optimal Algorithms for Bubble Sort Based Non-Manhattan Channel Routing, May 1994. 144. TD Computer-Aided Design of Integrated Circuits and Systems, IEEE Transactions Volume: 13 Issues, pp. 603-609. Chen, H., Routing L-Shaped Channels in Nonslicing-Structure Placement. 24th ACM-IEEE Design Automation Conference, pp. 152-165, 1987. 146 Chen, H. et al., Physical Planning of On-Chip Interconnect Architectures, 2002, IEEE, International Conference, pp. 30-35 Chen, S.-S. et al., A New Approach to the Ball Grid Array Package Routing, IEICE Trans. Fundamentals, Vol. E82-A, No. 11, November, 1999, pp. 2599-2608. Cheng, K. et al., Manhattan or Non Manhattan? A Study of Alternative VLSI Routing Architectures, pp. 47-52, 2000. 149 Cheng, K., Steiner Problem in Octilinear Routing Model, A Thesis submitted for the Degree of Master of Science, National University Singapore, 1995, pp. 1-122. 150 Chiang, C. et al., Wirability of Knock-Knee Layouts with 45° Wires, IEEE Transactions on Circuits and Systems, Vol. 38, Issue 6, pp 613-624, June 1991. Cong. J. et al., Efficient Heuristics for the Minimum Shortest Path Steiner Arborescence Problem with 151 Applications to VLSI Physical Design, Cadence Design Systems, pp.88-95.

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	RELATED U.S. PATENT APPLICATIONS						
	Examiner* Cite		Name of Patentee or Applicant of Cited Document	Date of Filing MM-DD-YYYY	Related Application Data		
71) 1.		10/066,060	SPLX.P0072	Steven Teig	01-31-2002	Application with similar, but not identical, specification and drawings as the present application.
	2.		10/066,160	SPLX.P0073	Steven Teig et al.	01-31-2002	Application with similar, but not identical, specification and drawings as the present application.
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	10).]	10/228,736	CDN.P0001	Steven Teig	08-26-2002	CIP of the present application
	11		10/229,311	CDN.P0002	Steven Teig	08-26-2002	CIP of the present application
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	1	9.	10/288,870	CDN.P0010	Steven Teig	11-06-2002	Continuation of the present application.
	2	20.	10/219,923	CDN.P0011	Steven Teig	08-14-2002	CIP of the present application
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	3	31.	10/215,923	CDN.P0022	Steven Teig	08-09-2002	Application that describes alternative path search technology to the path search technology described in the present application.
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791	√ 3.	4.	10/232,795	CDN.P0025	Steven Teig	08-28-2002	Application that describes alternative path search technology to the path search

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	36.	10/233,312	CDN.P0027	Steven Teig	08-28-2002	Application that describes alternative path search technology to the path search technology described in the present application.	
	37.	10/227,016	CDN.P0028	Steven Teig	08-23-2002	Application that describes alternative path search technology to the path search technology described in the present application.	
	38.	10/226,482	CDN.P0029	Steven Teig	08-23-2002	Application that describes alternative path search technology to the path search technology described in the present application.	
	39.	10/285,844	CDN.P0030	Steven Teig	10-31-2002	Application that describes alternative path search technology to the path search technology described in the present application.	
	40.	10/286,253	CDN.P0031	Steven Teig	10-31-2002	Application that describes alternative path search technology to the path search technology described in the present application.	
	41.	10/288,033	CDN.P0032	Steven Teig	11-05-2002	Application that describes alternative path search technology to the path search technology described in the present application.	
	42.	10/335,179	CDN.P0033	Steven Teig	12-31-2002	Application that describes alternative path search technology to the path search technology described in the present application.	
401	43.	10/285,758	CDN.P0035	Steven Teig	10-31-2002	Application that describes alternative path search technology to the path search technology described in the present application.	

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A MADIN **Application Number** 10/076,121 Substitute for form 1449A/PTO Filing Date 2/12/2002 INFORMATION DISCLOSURE First Named Inventor Steven Teig STATEMENT BY APPLICANT Group Art Unit 2825 (use as many sheets as necessary) **Examiner Name** Do, Thuan Sheet 4 of 4 **Attorney Docket Number** SPLX.P0081

	RELATED U.S. PATENT APPLICATIONS							
40	44.	10/286,598	CDN.P0036	Steven Teig	10-31-2002	Application that describes alternative path search technology to the path search technology described in the present application.		
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